## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No	09/755,673
	January 5, 2001
	Leonard Forbes, et al
	Micron Technology, Inc
	2823
Examiner	K.D. Nguyer
Attorney's Docket No	Ml22-1531
Title	Methods of Forming Capacitor Structures

## SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Reference –See Attached Form PTO-1449

In compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98, your attention is directed to the United States patents listed on the attached Form PTO-1449. No admission is made regarding whether all the submitted references are prior art.

This Supplemental Information Disclosure Statement is being filed together with the filing of a Request for Continued Examination (RCE) Application. Therefore, no fee is believed to be required. However, in the event that a fee is required for filing this Supplemental Information Disclosure Statement, please charge the fee specified under 37 C.F.R. §1.17(p) to Deposit Account No. 23-0925. Please credit Deposit Account No. 23-0925 with any overpayment of the above fee.

Citation of these references is respectfully requested.

Respectfully submitted,

Dated: 9-26-06

By:

D. Brent Kenady Reg. No. 40,045 Form PTO-1449

## U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO. MI22-1531

APPLICANT: Leonard Forbes, et al.

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SE OF ART CITED BY APPLICANT (Usa several sheets if necessary)

FILING DATE January 5, 2001

GROUP 2823

U.S. PATENTO CHIMENO

SEP 8 & 2006

*Examiner's Initials		Document Number	Date	Name	Class	Subclass	Fiting Date If Appropriate
<u>_</u> _	AA	2002/0000598	01/02	Kang et al.			
,	AB	2002/0045312	04/02	Zheng et al.			
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	AT						
	AU						
	AV						
	AW						

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.